

Notice of References Cited	Application/Control No. 10/056,437	Applicant(s)/Patent Under Reexamination CHO ET AL.	
	Examiner Shun Lee	Art Unit 2878	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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	U	Romero et al. "An analytical model for the photodetection mechanisms in high electron mobility transistors", IEEE Transactions on Microwave Theory and Techniques, Vol. 44, no. 12, (December 1996), pp. 2279-2287.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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